

AMAA 2012

Far Infrared Imaging Sensor for mass Production of Night Vision & Pedestrian Detection Systems

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Silicon infrared imaging sensors



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Outline

- **Automotive applications**
- **FIR imaging sensor**
- **Thermal imaging for automotive applications**
- **Non imaging applications**
- **Conclusion**



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FIR imaging sensors for automotive applications

Far infrared ($\lambda = 10 \mu\text{m}$) is well adapted to pedestrian detection because of:

- High contrast based on object thermal detection
- Completely passive imaging system

Two types of applications:

- Imaging applications
 - *Enhanced Driver Vision (EDV)*
 - *Pedestrian Detection System (PDS)*
- Short distance Detection applications
 - *Front & Back viewer*
 - *Occupancy detection*

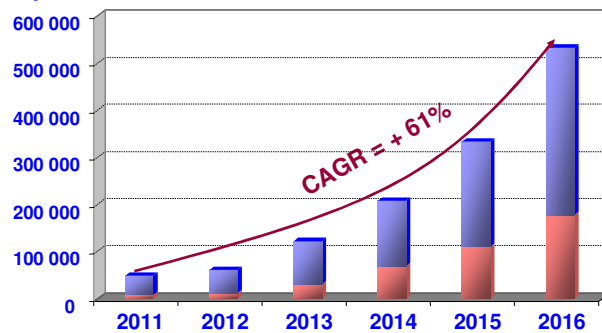


Imaging application – Market forecasts

Enhanced Driver Vision & Pedestrian Detection System



Units / year



Tier 1 Aftermarket

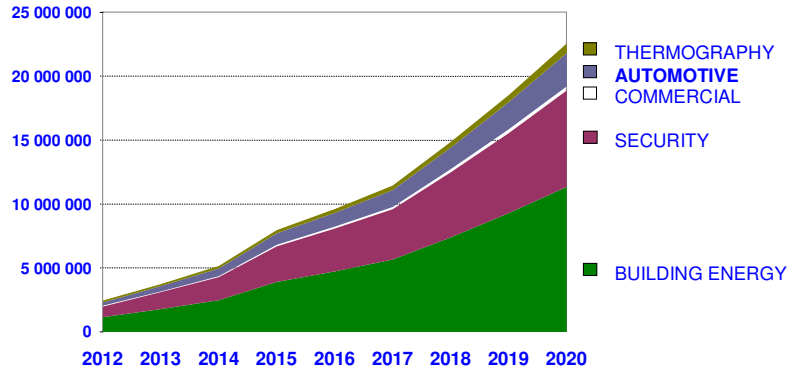
Forecasts from Yole Développement

Detection applications - Market forecasts

It exists an important need of 2D arrays (# 64 x 64) which will be addressed mainly by microbolometer arrays and Thermopile arrays



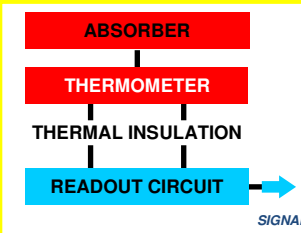
Units / year



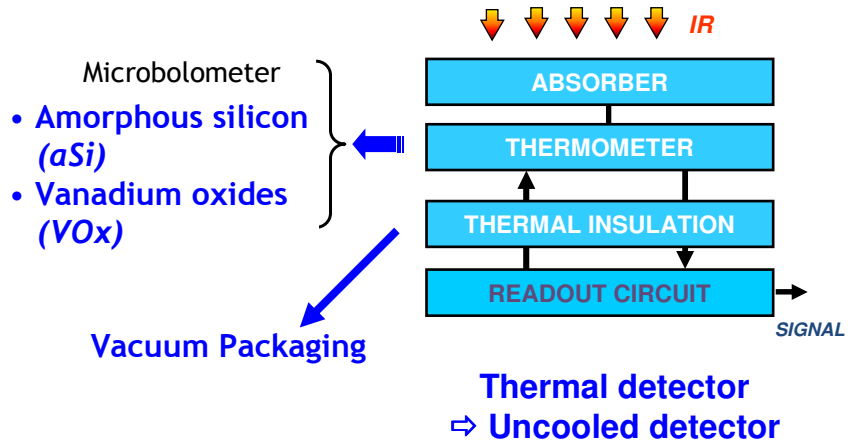
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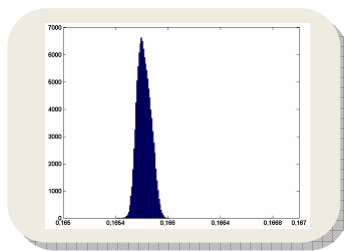
FIR imaging sensor background



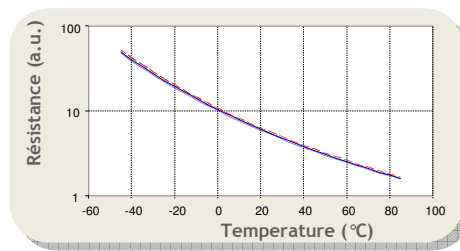
Amorphous silicon background

aSi microbolometer: simple and uniform behavior

$$R_{\text{bolo}} = R_0 \cdot \exp(E_a/kT)$$



E_a distribution histogram
aSi 384 x 288 / 17 μ m array

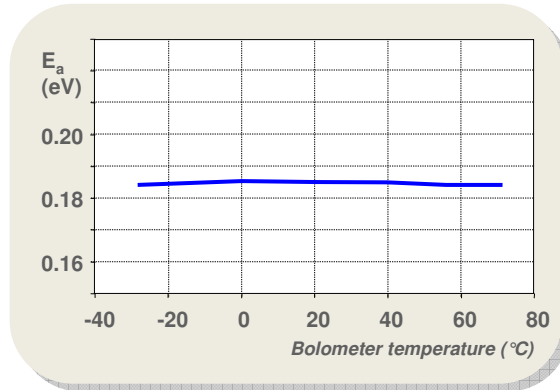


Uniform pixel behavior

$E_a \sigma/m = 0.034\%$

Amorphous silicon background

aSi microbolometer: Predictable over large range
-40 ° to +85 °C operating temperature



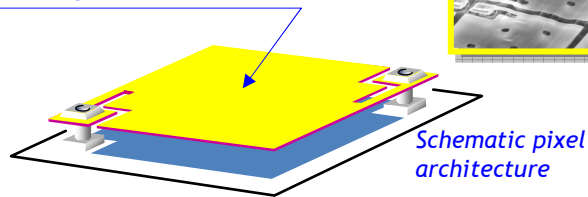
In addition to being very uniform over an array, E_a is extremely stable with FPA temperature.



Easier TEC-less operation
Easier Shutter-less operation

Amorphous silicon technology

Only active layers in pixel structure



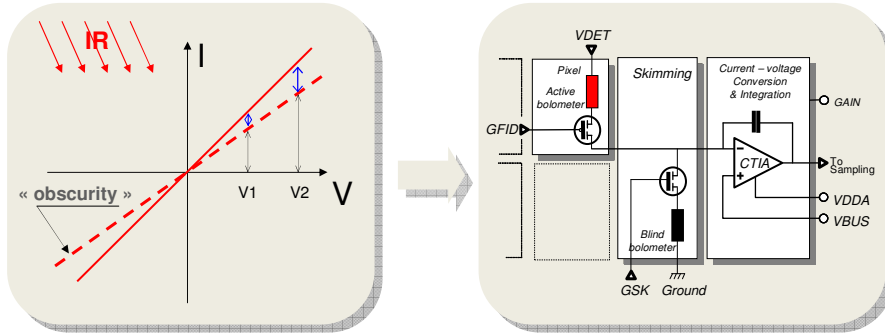
☑ Smaller suspended mass = Smaller thermal time constant

⇒ Thermal time constant ≤ 10 ms

+ High thermal insulation (shorter leg length ⇒ higher Fill Factor)

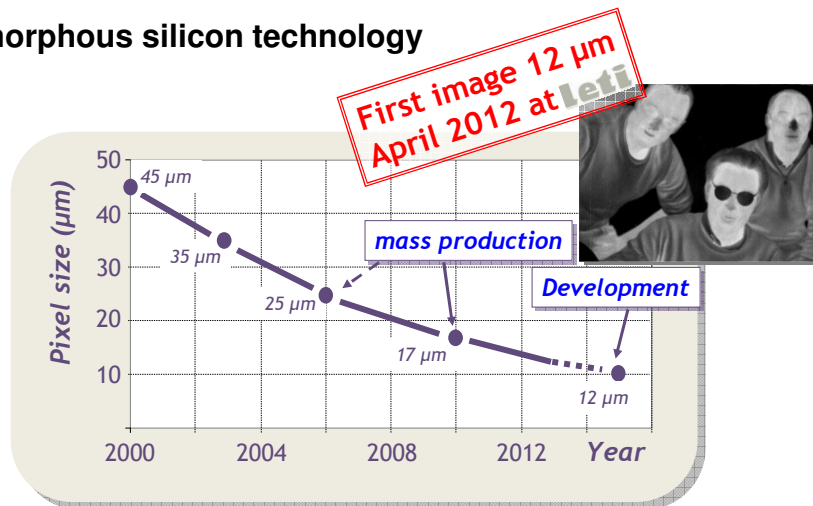
+ Low defect density & high uniformity

Microbolometer Readout IC Design



$Signal = f(IR \ \& \ bias) \Rightarrow$ necessity to introduce a skimming function

Amorphous silicon technology



Development of amorphous silicon technology at ULIS
in cooperation with CEA / LETI

Outline

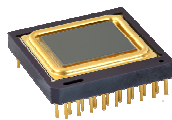
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Imaging application

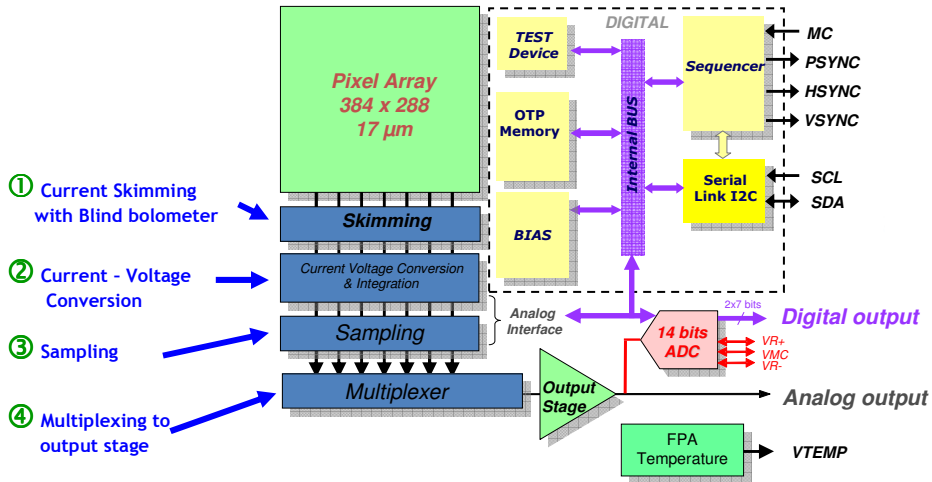
Needs for a ¼ VGA imaging sensor
currently tested by Tiers 1 and
Equipment manufacturers

⇒ Development of a new detector
¼ VGA / 17 μm pixel pitch

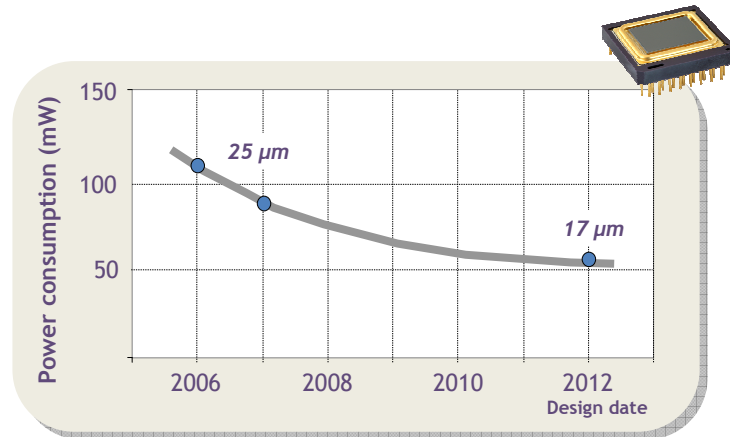


Imaging application

⇒ Development of a new detector 1/4 VGA / 17 μm pixel pitch



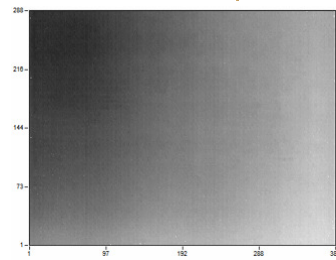
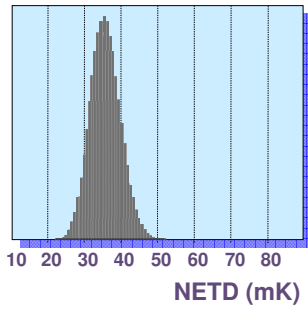
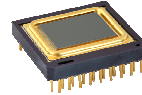
Imaging application with 384 x288 / 17 μm IRFPA



Improvement of 1/4 VGA power consumption (analog output)

Imaging application with 384 x288 / 17 μm IRFPA

Device performance



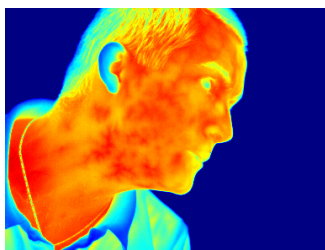
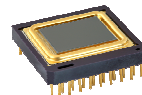
RFPN = 250 μV
= 75% of rms noise

Mean NETD* : 35 mK (f/1, 300 K, 30 Hz)
Thermal time constant : ≤ 10 ms

* NETD: Noise Equivalent Temperature Difference # detector sensitivity

Imaging application with 384 x288 / 17 μm IRFPA

Device performance



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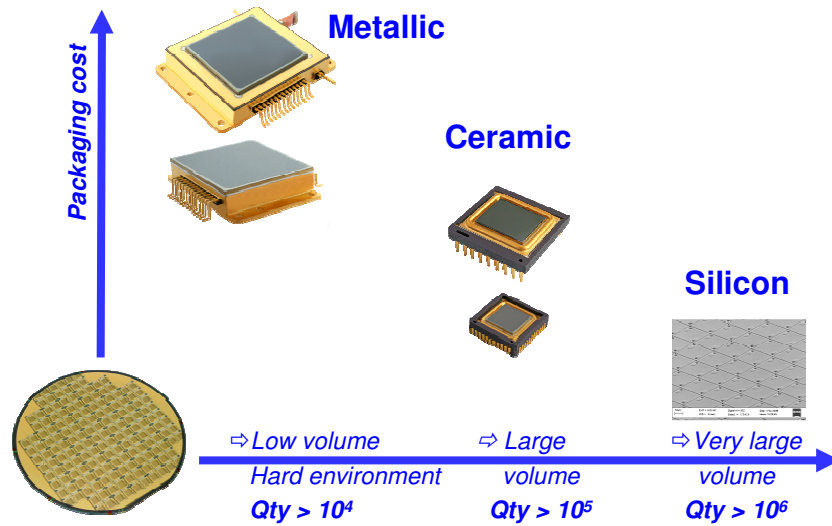


Non Imaging application with microbolometer

	Thermopile/ Pyroelectric	μbolometer	Comments
NETD	-- 0.15 °C @1Hz, 100 °C	++ 0.05 °C @50Hz, 20 °C	
Size / pixel pitch	-- 100 to 250 μm	++ 17 to 25 μm	
Frame rate	--	++	
Uniformity	+	+	Both require calibration process
Vacuum	- Chip Level Package	+ Pixel Level Package	Both require vacuum package
Operating range	+	++ -40 °C to +85 °C	Performance stability over the operating temperature
Manufacturability	+	+	

PIR detectors versus Microbolometer detectors Comparison

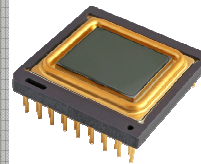
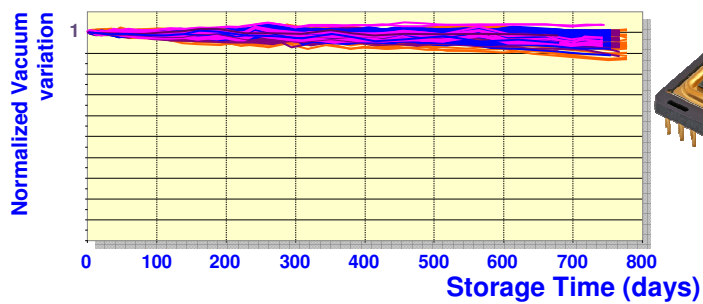
Microbolometer Packaging technology



Ceramics packaging technology

Vacuum Life time evaluation

Storage temperature — 90 °C, —110 °C, —130 °C and —170 °C



Vacuum Life time > 15 years

Compliant with Automotive Standards AEC-Q-100 Grade 3 (TC, HTSL)

No getter activation = no maintenance

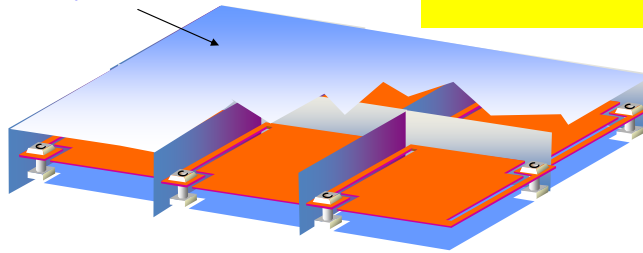
Silicon packaging technology: Pixel Level Packaging

For small sensor generation

leti Advanced vacuum Pixel Level Packaging

Single-pixel
micro-capsule

Front end manufacturing
process



Silicon packaging technology: Pixel Level Packaging

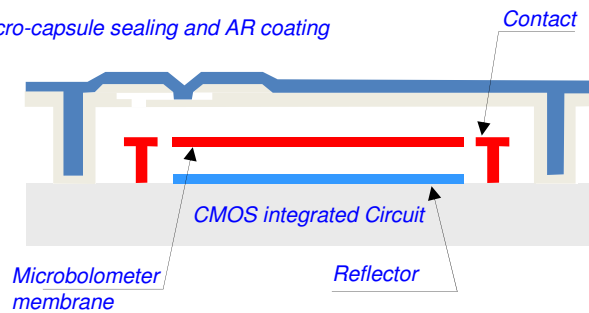
① Sacrificial layer

② Sacrificial layer etching

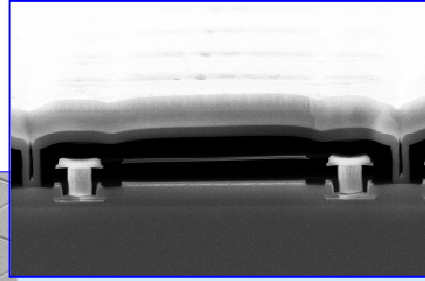
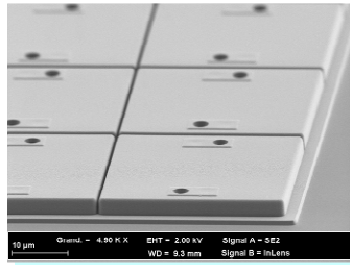
③ Micro-capsule build up

④ Micro-capsule evacuation

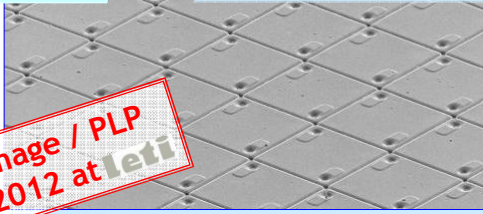
⑤ Micro-capsule sealing and AR coating



Silicon packaging technology: Pixel Level Packaging

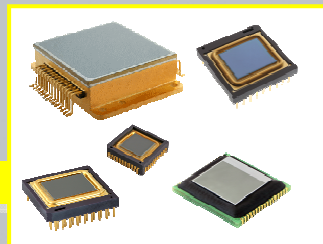


First image / PLP
April 2012 at **leti**



Outline

- Automotive applications
- Uncooled IR Focal Plane Array
- Imaging automotive application
- Non imaging application
- **Conclusion**



Conclusion

Key benefits of a-Si are extensive

a-Si physical properties

*Thin microbridge architecture / fast sensor
Enhanced thermal insulation / fast & sensitive sensor
Easy downscaling for small pixel*

a-Si thin film uniformity

a-Si is Compatible with silicon technology for advanced packaging techniques

Conclusion

Key benefits of a-Si imaging sensor for automotive

a-Si paves the way to very large volume applications required by automotive security enhancement like:

- ✓ Long distance pedestrian detection (DVE)
- ✓ Short distance pedestrian detection (small arrays)
- ✓ Blind spot detection
- ✓ HVAC management & seat occupancy

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